

**Search Notes**

Application/Control No.

10/629,829

Examiner

Y. Lee

Applicant(s)/Patent under  
Reexamination

ISHIZUKA ET AL.

Art Unit

2621

**SEARCHED**

Class	Subclass	Date	Examiner
375	240.01 240.12 240.28 **	3/14/2007	YL
H04N	7/12		
update	search	8/29/2007	YL
update	search	3/13/2008	YL
375	240.25		
update	search	10/28/2008	YL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR